SDLS209

- Shifts 4-Bits of Data to 0, 1, 2 or 3 Places Under Control of Two Select Lines
- Three-State Outputs for Bus Organized
 Systems
- 6.5 ns Typical Data Propagation Delay

description

The 'S350 is operationally equivalent to a 4-input multiplexer with the inputs connected so that the select code causes shifts of the data word. This makes it possible to perform shifts of 0, 1, 2, or 3 places on words of any length, with suitable interconnection.

A 7-bit data word is introduced at the D inputs and is shifted according to the code applied to the select inputs S0 and S1. Y0 through Y3 are 3-state outputs controlled by an output enable, \overline{OE} . When \overline{OE} is low, the outputs follow the selected data inputs; when \overline{OE} is high, the outputs are in a high-impedance state. This feature allows shifters to be cascaded on the same output lines or to a common bus. The shift function can be logical with zeroes pulled in at either or both ends of the shifting field, arithmetic with the sign bit repeated during a shift down, or end-around with the data word forming a continuous loop.

FUNCTION TABLE

INPUTS				OUTPUTS					
ŌĒ	\$1	S 0	YO	Y1	¥2	¥3			
н	X	Х	Z	Z	Z	z			
[L	L	L	DO	D1	D2	D3			
ι	L	Н	D-1	D0	D1	D2			
1 1.	н	L	D-2	D-1	D0	D1			
L	н	н	D-3	D-2	D-1	D0			

D2745,	DECEMBER	1983 -	_	REVISED	MARCH	1988
--------	----------	--------	---	---------	-------	------

SN54S350 J PACKAGE SN74S350 D OR N PACKAGE
(TOP VIEW)

D-3	U_{16}	Dvcc
_D-2∐2	2 15	[]Y0
_ D-1∐3	3 14	<u> Y1</u>
00[]4	13] ΟΕ
01∐!	5 12	[]Y2 ⊡
D2[] (5 11]Y3
;	7 10	∏so _
	3 9] S1

SN54S350 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic equations

 $Y_{1} = \overline{s0} \ \overline{s1} \ D0 + s0 \ \overline{s1} \ D.1 + \overline{s0} \ S1 \ D.2 + s0 \ S1 \ D.3$ $Y_{1} = \overline{s0} \ \overline{s1} \ D1 + s0 \ \overline{s1} \ D0 + \overline{s0} \ S1 \ D.1 + s0 \ S1 \ D.2$ $Y_{2} = \overline{s0} \ \overline{s1} \ D2 + s0 \ \overline{s1} \ D1 + \overline{s0} \ S1 \ D0 + s0 \ S1 \ D.1$ $Y_{3} = \overline{s0} \ \overline{s1} \ D3 + s0 \ \overline{s1} \ D2 + \overline{s0} \ S1 \ D1 + s0 \ S1 \ D1 + s0 \ S1 \ D0$

PRODUCTION DATA decuments contain information current as of publication data. Products conform to specifications per the terms of Taxas instruments standard warranty. Production processing does not accessarily include tasting of all perameters.



· · · ·



logic symbol[†] 0E (13) **ISHIFTER** EN (10) SO 0` $G\frac{0}{3}$ ST (9) 10 -11 1 ∇ 12 -2 (7) D3 Z10 13 -3 (6) D2 Z11 11 ٠û (<u>12)</u> Y2 12 1 (5) ∇ Z12 D1 13 • 2 (4) 14 - 3 DO Z13 12 -0 (3) D-1 Z14 13 -- 1 (14) - 71 ∇ (2) Z15 14 -2 D-2 15 - 3 (1) D-3 Z16 13 -**-** 0 (15) YO 14 - 1 ∇ 15 - 2 16 3

[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for DW, J, and N packages.

schematics of inputs and outputs





;



ł

1

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (see Note 1)	
Input voltage	
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range: SN54S350	
SN74S350	0°C to 70°C
Storage temperature range	

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

. 1

	s	SN54S350		SN74S350			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	. 🗸
VIH High-level input voltage	2			2			V
VIL Low-level input voltage			0.8			0.8	~
IOH High-level output current			- 2			- 6.5	mA
IOL Low-level output current			20			20	mΑ
TA Operating free-air temperature	- 55		125	0		70	°Ç

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	DAMETER		Trat concircent		S	N54S35	0	SN74S350			
24	RAMETER		TEST CONDITIONS [†]	MI	N	TYP	MAX	MIN	TYP	MAX	
VIK		V _{CC} = MIN,	ί _ι = − 18 mA				- 1.2			- 1.2	l v
∨он		V _{CC} ≈ MIN, I _{OH} ≖ MAX	V _{IH} =2V, V _{IL} =	0.8 V, 2	.4	3,4		2.4	3.4		v
VOL		V _{CC} = MIN, I _{OL} = 20 mA	V _{1H} = 2 V, V _{1L} =	0.8 V,			0.5			0.5	V
^I OZH		V _{CC} = MAX,	Vo = 2.4 V				50			50	μA
IOZL		V _{CC} = MAX,	V _O = 0.5 V				- 50			-50	μA
4		V _{CC} = MAX,	V ₁ = 5.5 V				1	1		1	mΑ
чн	D-2, D-1, D-0, D1, D2 inputs	D-1, D-0,	V ₁ = 2.7 V		75				75		μA
	All others						50	1		50	1
۱L	D-2, D-1 D-0, D1, D2 inputs	V _{CC} ≖MAX,	V ₁ = 0.5 V				- 3			- 3	mA
	All others						- 2	1		- 2	1
los §		V _{CC} ≃ MAX,	V _O = 0	- 4	10		- 100	- 40		- 100	mA
lcc		V _{CC} = MAX, All inputs = GN	•			60	85		60	85	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

1 All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

\$Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.



PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	MIN TYP	MAX	UNI	
^t PLH	H Select	Απν Υ			5	9	ns
tPHL		Addy T			8	12	ns
tPLH			R _{1.} = 280 Ω,	CL = 15 pF	11	17	ns
^t PHL			ηL - 200 32,	of - tobe	13	20	ns
^t PZH						19.5	ns
^t PZL	ŌĒ	Απγ Υ				21	ns
tPHZ					8	13	ns
tPLZ	OE	Any Y	R _L = 280 Ω,	CL=5pF	10	15	ns

.

.....

٠

_ ----

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



•

·•









.....

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.

Copyright © 1996, Texas Instruments Incorporated